


<b>Search Notes</b>  	<b>Application/Control No.</b>  10552601	<b>Applicant(s)/Patent Under Reexamination</b>  CHIN ET AL.
	<b>Examiner</b>  CHUONG T HO	<b>Art Unit</b>  2419

SEARCHED			
Class	Subclass	Date	Examiner
370	412, 413, 418, 351, 389, 390, 395, 401, 411	12/25/08	CH
370	395.1	12/28/08	CH

SEARCH NOTES		
Search Notes	Date	Examiner
West (text search, class search)	12/28/08	CH
East	12/28/08	CH
STN	12/28/08	CH
IEEE	12/28/08	CH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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